

<b>Notice of References Cited</b>		Application/Control No. 10/591,664	Applicant(s)/Patent Under Reexamination FUKUOKA ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0246391	10-2008	Iwakuma et al.	313/504
*	B	US-2007/0194701	08-2007	Ito et al.	313/506
*	C	US-2006/0220538	10-2006	Kuma, Hitoshi	313/506
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	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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